

Fabrication of Mn_2VAl full-Heusler epitaxial thin films for spin wave devices

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The ferromagnetic materials with low magnetic damping are promising for waveguides on spin wave propagating devices, because propagation length of spin waves is expected to be long in low damping materials. Mn_2VAl full-Heusler alloy is theoretically predicted to be half-metal and is expected to have low magnetic damping constant. Mn_2VAl is known as ferrimagnet, however, its magnetic damping have not been reported. In this work, we fabricated highly ordered Mn_2VAl epitaxial thin films by using magnetron sputtering and characterized the structural and magnetic properties.

We fabricated four series of Mn_2VAl thin films on $\text{MgO}(001)$ substrates as follows. A : Mn_2VAl (50 nm), $T_s = 300\text{--}700^\circ\text{C}$, B : Cr (40 nm)/ Mn_2VAl (50 nm), $T_a = 300\text{--}700^\circ\text{C}$, C : MgO (20 nm)/ Mn_2VAl (50 nm), $T_a = 300\text{--}700^\circ\text{C}$, D : MgO (20 nm)/ Mn_2VAl (50 nm), $T_s = 300\text{--}700^\circ\text{C}$. The films were capped by 3-nm-thick Ta. The crystal structure and magnetic properties were measured by XRD and VSM, respectively. The damping constant was evaluated by ferromagnetic resonance (FMR).

Figs. 1 and 2 show T_a and T_s dependences of order parameter of L_{21} phase ($S_{L_{21}}$) and saturation magnetization (M_s). As shown in Fig. 1, Mn_2VAl had L_{21} structure at $500\text{--}600^\circ\text{C}$ in all series. In series D, we obtained the highest L_{21} -order parameter $S_{L_{21}} \sim 0.75$ and the value was much higher than $S_{L_{21}} \sim 0.45$ in the previous report ^[1]. Saturation magnetization showed maximum at around $500\text{--}600^\circ\text{C}$ in all series of Mn_2VAl films, and the highest M_s value was 242 emu/cc at $T_s = 500^\circ\text{C}$ in series A. The observed magnetization was much higher than reported value of 150 emu/cc ^[1], but lower than theoretical value of 300 emu/cc. We will report magnetic damping constant in these L_{21} ordered Mn_2VAl films. This work was partially supported by KAKENHI (24226011) and Interdepartmental Doctoral Degree Program for Multi-dimensional Material Science Leaders. [1] T. Kubota *et al.*, J. Magn. Soc. Jpn., **34**, 100-106 (2010).

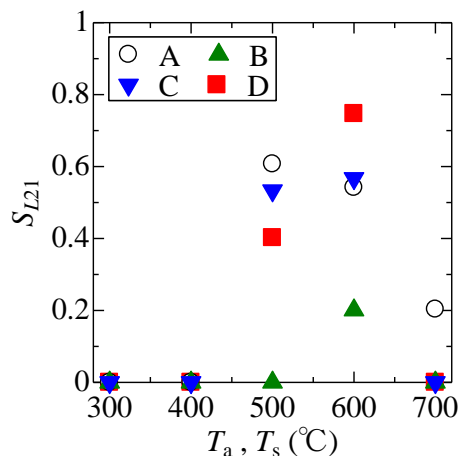


Fig. 1 T_a and T_s dependence of order parameter of L_{21} phase $S_{L_{21}}$

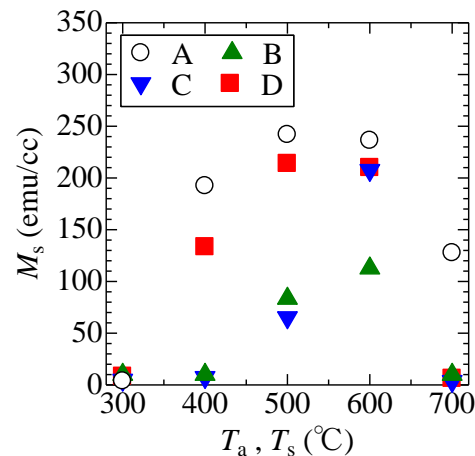


Fig. 2 T_a and T_s dependence of saturation magnetization M_s